

# -30V P-Channel Enhancement Mode MOSFET

## **Description**

The SX20P03S uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

### **General Features**

V<sub>DS</sub> = -30V I<sub>D</sub> =-20A

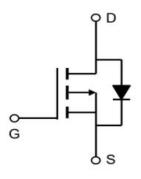
 $R_{DS(ON)}$  <7.5m $\Omega$  @ Vgs=-10V

# **Application**

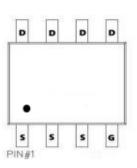
Lithium battery protection

Wireless impact

Mobile phone fast charging







Absolute Maximum Ratings (TC=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	-30	V
VGS	Gate-Source Voltage	±20	V
ID@TC=25℃	Continuous Drain Current, VGS @ -10V1	-20	А
ID@TC=100°C	Continuous Drain Current, VGS @ -10V1	-16.8	A
IDM	Pulsed Drain Current2	-120	A
EAS	Single Pulse Avalanche Energy3	125	mJ
PD@TC=25℃	Total Power Dissipation4	69	W
TSTG	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
RθJA	Thermal Resistance Junction-Ambient 1	85	°C/W
R0JC	Thermal Resistance Junction-Case1	1.6	°C/W





Electrical Characteristics (T<sub>J</sub>=25 <sup>o</sup>C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , Ip=-250uA	-30	-34		V	
△BVbss/△T	BVDSS Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =-1mA		-0.0232		V/°C	
RDS(ON)	Static Drain-Source On-Resistance	Vgs=-10V , Ip=-20A		5.2	7.5	mΩ	
		Vgs=-4.5V , Ip=-15A		8.0	11		
V <sub>G</sub> S(th)	Gate Threshold Voltage	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250uA	-1.2	-1.4	-2.5	V	
$\triangle V$ GS(th)	V <sub>GS(th)</sub> Temperature Coefficient	- V65-V55 ; ID - 2000/ (		4.6		mV/℃	
	Drain-Source Leakage Current	V <sub>DS</sub> =-24V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			-1	uA	
loss		V <sub>DS</sub> =-24V , V <sub>GS</sub> =0V , T <sub>J</sub> =55℃			-5		
lgss	Gate-Source Leakage Current	Vgs=±20V , Vps=0V			±100	nA	
gfs	Forward Transconductance	VDS=-5V , ID=-30A		30		S	
Rg	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz		9.8		Ω	
Qg	Total Gate Charge (-4.5V)			35		nC	
Qgs	Gate-Source Charge	V <sub>DS</sub> =-15V , V <sub>GS</sub> =-4.5V b=-20A		9.9			
Qgd	Gate-Drain Charge	D20A		10.5			
Td(on)	Turn-On Delay Time	V 45V V 40V		10.8		ns	
Tr	Rise Time	V <sub>DD</sub> =-15V , V <sub>GS</sub> =-10V , R <sub>G</sub> =3.0Ω		13.2			
Td(off)	Turn-Off Delay Time			73			
Tf	Fall Time	b=-20A		35			
Ciss	Input Capacitance			3520			
Coss	Output Capacitance	V <sub>DS</sub> =-15V , V <sub>GS</sub> =0V , f=1MHz		465		pF	
Crss	Reverse Transfer Capacitance			370			
ls	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-70	Α	
Іѕм	Pulsed Source Current	VG-VD-0V , Force Current			-130	Α	
VsD	Diode Forward Voltage	Vgs=0V , Is=-1A , Tյ=25℃			-1.3	V	
trr	Reverse Recovery Time	I <sub>F</sub> =-20A , dI/dt=100A/μs ,		25		nS	
Qrr	Reverse Recovery Charge	TJ=25℃		10		nC	

#### Note:

- 1. The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.
- $\ensuremath{\mathsf{2}}_{\ensuremath{\mathsf{N}}}$  The data tested by pulsed , pulse width .The EAS data shows Max. rating .
- $3 {\ \ }^{\scriptscriptstyle \sim}$  The power dissipation is limited by  $175 {\ \ \ }^{\scriptscriptstyle \sim}$  junction temperature
- 4、EAS condition: TJ=25°C , VDD= -24V, VG= -10V, RG=7 $\Omega$ , L=0.1mH, IAS= -40A
- 5. The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.

www.sxsemi.com



# **Typical Characteristics**

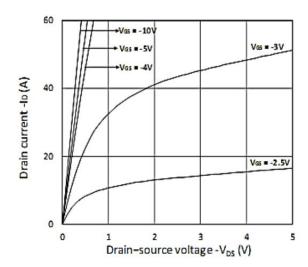


Figure 1. Output Characteristics

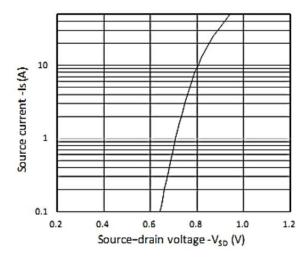


Figure 3. Forward Characteristics of Reverse

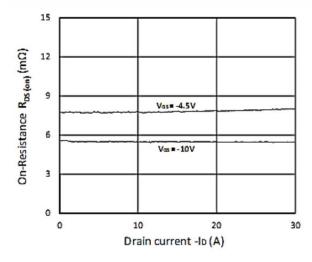


Figure 5. R<sub>DS(ON)</sub> vs. I<sub>D</sub>

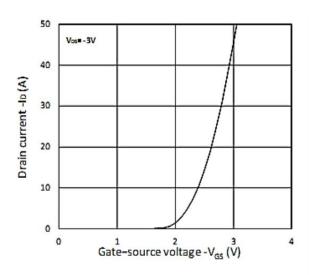


Figure 2. Transfer Characteristics

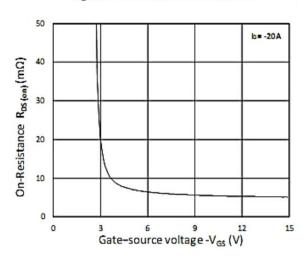


Figure 4. R<sub>DS(ON)</sub> vs. V<sub>GS</sub>

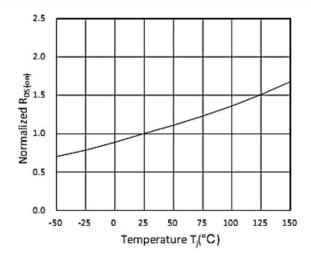


Figure 6. Normalized  $R_{DS(\alpha n)}$  vs. Temperature



# **Typical Characteristics**

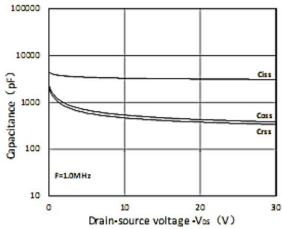


Figure 7. Capacitance Characteristics

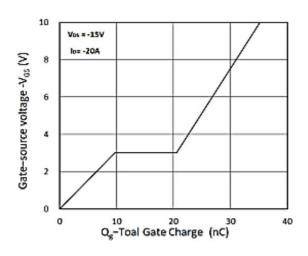
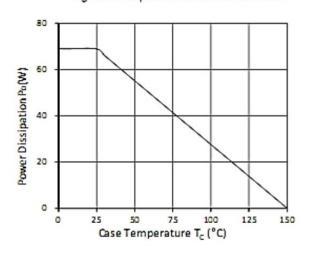


Figure 8. Gate Charge Characteristics



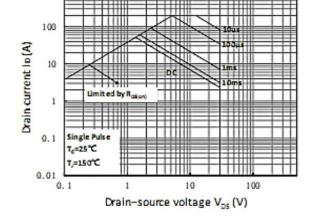
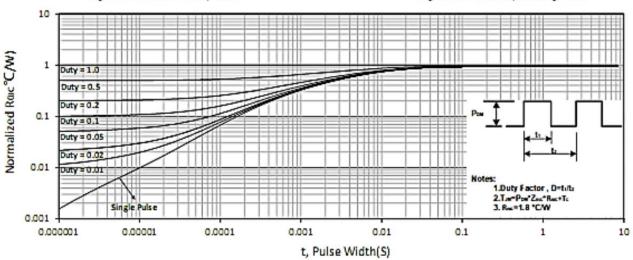


Figure 9. Power Dissipation

Figure 10. Safe Operating Area

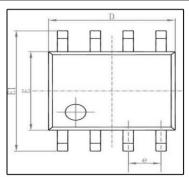


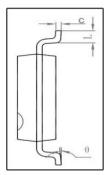
1000

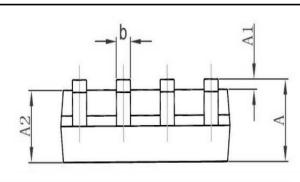
Figure 11. Normalized Maximum Transient Thermal Impedance



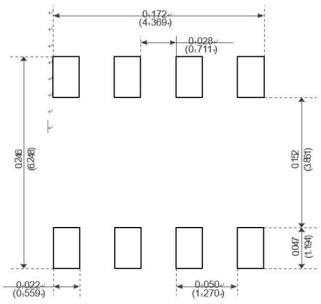
# Package Mechanical Data-SOP-8L







Cl 1	Dimensions I	n Millimeters	Dimensions	In Inches
Symbol	Min	Max	Min	Max
Α	1. 350	1. 750	0. 053	0.069
A1	0. 100	0. 250	0. 004	0.010
A2	1. 350	1. 550	0. 053	0.061
b	0. 330	0. 510	0. 013	0. 020
С	0. 170	0. 250	0.006	0. 010
D	4. 700	5. 100	0. 185	0. 200
E	3. 800	4. 000	0. 150	0. 157
E1	5. 800	6. 200	0. 228	0. 244
е	1. 270	(BSC)	0.050	(BSC)
L	0. 400	1. 270	0. 016	0.050
θ	0°	8°	0°	8°



Recommended Minimum Pads-

**Package Marking and Ordering Information** 

Product ID	Pack	Marking	Qty(PCS)		
TAPING	SOP-8L		3000		

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